Design of a DI model-based Content Addressable Memory for Asynchronous Cache

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ABSTRACT

This paper presents a novel approach in the design of a CAM for an asynchronous cache. The architecture of cache mainly consists of four units: control logics, content addressable memory, completion signal logic units and instruction memory. The pseudo-DCVSL is useful to make a completion signal which is a reference for handshake control. The proposed CAM is a very simple extension of the basic circuitry that makes a completion signal based on DI model. The cache has 2.75KB CAM for 8KB instruction memory. We designed and simulated the proposed asynchronous cache including CAM. The results show that the cache hit ratio is up to 95% based on pseudo –LRU replacement policy.

Keywords: Cache, CAM, DCVSL, completion signal

1. INTRODUCTION

The generic concept associated with implementation of cache is to reduce the average access time of a main memory in the CPU [1]. The instruction cache is both smaller and a faster memory that stores copies of recent instructions fetched from program memory. The average latency of cache access is smaller when compared with the latency of a main memory access [2]. In general, the energy consumption of a cache accounts for significant part of the energy utilization in an embedded system. For instance, the cache employing the sleep mode approach prevents cache access until it is woken up. Within such design paradigm, asynchronous circuit techniques appear as a natural choice to realize the sleep mode functionality [3]. Thus, implementation of a handshaking protocol becomes responsible for activating active blocks, leaving other blocks in the wait-state. The asynchronous circuit employing delay-insensitive (DI) delay model is an option capable of both energy efficiency as well as performance enhancement. This paper presents a novel asynchronous instruction cache suitable for self-timed system. There are two salient features when compared with the conventional asynchronous cache designs. First, the cache design employs DI delay model, which operates correctly assuming positive, bounded but unknown delays in gates as well as wires communicating with main memory and CPU that employ bound delay model. Second, we employ content addressable memory (CAM) instead of the more conventional random access memory (RAM) for the cache tag storage which reduces the power consumption.

Section II presents the proposed asynchronous cache architecture, CAM, completion signal generation using differential cascade voltage switch logic (DCVSL). Simulation results and conclusions are provided in sections III and IV respectively.

2. ASYNCHRONOUS CACHE ARCHITECTURE

A self-timed circuits have a number of computation blocks that are coupled through interconnection blocks. Main architecture of the asynchronous cache is shown in figure 1 that includes CAM, handshake block and related blocks. Since there is no system clock to coordinate operations between computational blocks, we employ handshake protocol [4]. The completion signal of a combinational block helps with the handshake protocol as reference signal in asynchronous circuit [5]. We design asynchronous cache using DI model for CAM and a bundled model for an external memory.

![Fig. 1 Main architecture of the proposed asynchronous cache](image-url)
First, an address in the Program Counter is loaded to the address bus. Then PC_req signal accesses the cache that loaded into CAM. If the address is in the CAM that is a match state, a completion signal is activated. Then PC_ack signal is enabled that it disables PC_req. The data in CAM memory is moved to the Instruction Register of CPU and the searching operation is finished. Timing diagram of the match state is shown in figure 2.

**Cache mismatch state**

First, the address in the Program Counter is loaded to the address bus. Then PC_req signal accesses the cache that enables the input latch of CAM. Therefore valid address is loaded into CAM. If the search operation is missed to find the address in CAM, PM_req signal is activated after bundled delay \( \Delta t \). The PM_req transfers the address to main memory. After finding data from main memory, PM_ack signal goes high. Thus the PC_ack loads an instruction to the Instruction Register. Mismatch state timing diagram is shown in figure 3.

### 2.1 CAM design

Content addressable memory (CAM) or associative memory, is a storage device, which can be addressed by its own contents [6]. Each bit of CAM cells includes comparison logic. An input data of CAM is simultaneously compared with all the stored data [7]. Main architecture of CAM block is shown in figure 4.

CAM cell has two basic functions: bit storage (as in RAM) and bit comparison (unique to CAM). Figure 5 and figure 6 show a conventional NAND-type CAM cell and a proposed NOR-type CAM cell, respectively. The bit storage in both cases is in an SRAM where cross-coupled inverters have data node \( D \) and \( \overline{D} \). In the figure 5 and figure 6, word line access NMOS transistors are used to read and write data in SRAM. Although some CAM cell implementations use lower area DRAM cells, typically, CAM cells use SRAM storage. The bit comparison, which is logically equivalent to an XOR of the stored bit and the search bit is implemented in a somewhat different fashion in the NOR and NAND cells [8].

#### Conventional NAND Cell

The NAND cell compares the stored bit, \( D \), and corresponding search data on the corresponding search lines, \( \overline{SL} \), using the tree transistors \( M_1 \), \( M_D \), and \( M_{\overline{D}} \), which are all typically minimum-size to maintain high cell density. We illustrate the bit-comparison operation of a conventional NAND cell with an example.
other match case when $SL = 0$ and $D = 0$. In this case, the transistor $M_B$ passes logic high to raise node $B$. The remaining cases, where $SL \neq D$, result in a miss condition, and accordingly node $B$ is logic “0” and the transistor $M_1$ is OFF. Node $B$ is a pass-transistor implementation of the XNOR function. The NAND nature of this cell becomes clear when multiple NAND cells are serially connected. In this case, the $M_{la}$ and $M_{lan}$ nodes are joined to form a word. A serial NMOS chain of all the $M_i$ transistors resembles the pull-down path of a CMOS NAND logic gate. A match condition for the entire word occurs only if every cell in a word is in the match condition. An important property of the NOR cell is that it provides a full rail voltage at the gates of all comparison transistors [9]. On the other hand, a deficiency of the NAND cell is that it provides only a reduced logic “1” voltage at node $B$, which can reach only $V_{DD} - V_{th}$ when search lines are driven to $V_{DD}$ (where $V_{DD}$ is the supply voltage and $V_{th}$ is the NMOS threshold voltage).

**Proposed NOR Cell**

The matched result of CAM is corresponding address of instruction memory. The proposed NOR cell implements the comparison between the complementary stored bit, $D$ (and $\overline{D}$), and the complementary search data on the complementary search line, $SL$ (and $SL$), using four comparison transistors, $M_1$ through $M_4$, which are all typically minimum-size to maintain high cell density. These transistors implement the pull-down path of a dynamic XNOR logic gate with inputs $SL$ and $D$. Each pair of transistors, $M_1$, $M_3$ and $M_2$, $M_4$ makes a pull-down path from the match line, $ML$, such that a mismatch of $SL$ and $D$ activates at least one of the pull-down paths, connecting $ML$ to ground. A match of $SL$ and $D$ disables both pull-down paths, disconnecting $ML$ from ground [10].

Match state timing diagram of CAM is shown in figure 7. When PC_req signal is enabled to high, following EN signal of latch is enabled. By disabling RES signal, valid address is taken into address latch. If the result of searching operation is matched, completion signal is activated. Else the result of searching operation is mismatched, completion signal is not activated.

![Fig. 7 Match state timing diagram of CAM](image)

When PC_req signal is disabled, EN signal of latch is disabled. After that RES signal of latch is enabled and at this time address latch is refreshed by 0. In addition, completion signal is replaced by 0. Mismatch state timing diagram of CAM is shown in figure 8.

![Fig. 8 Mismatch state timing diagram of CAM](image)

**2.2 Completion signal using DCVSL gate**

Self-timed circuits consist of number of computation blocks coupled through interconnection blocks. The system employs a handshake protocol instead of the more classical clock signal. The combinational block generates a completion signal that indicates the combinational block is allowed to move a new operation. DCVSL is used to make a completion signal with a very simple extension of the basic circuitry. This led to self-timed designs with minimal overhead for completion circuitry. A generalized DCVSL gate is shown in figure 9. DCVSL gate has NMOS trees which implements the logic function with two output nodes $Q$ and $\overline{Q}$.
For pre-charge phase during input $I$ is low, nodes $Q$ and $\overline{Q}$ are high. In the evaluate phase, a path of the NMOS trees will be conducting, causing one of the nodes $Q$ and $\overline{Q}$ to be discharged. Therefore, result of evaluate phase is complementary values on the outputs. Completion signal required by the self-timed components is generated by making NAND gate of two outputs. Figure 10 shows a circuit for completion signal detecting match state. Table 1 shows truth table for CAM cell.

3. SIMULATION RESULTS

The asynchronous cache is 32 bit x 2048 corresponding to 8Kbyte. CAM is decoding 2048 rows of the cache memory. Thus, the total size of CAM is, $2048 \times 11$ bit, 2.75KB. LSB 11 bits is used to identify an address. Figure 11 shows CAM is handling the instruction memory.

We implemented CAM block in VHDL coding. A CAM cell described the latch for bit-line, the latch for search-line and XNOR gate for comparing bit-line and search-line. If all data of search-lines and bit-lines are equal, that will be matched. All CAM cell’s match-lines connect the AND gates. After that outputs of AND gates connected to DCVSL gates. Finally, outputs of DCVSL gates connected to OR gate, that will be generate completion signal. Figure 12 shows the RTL architecture of CAM. Figure 13 shows VHDL coding simulation results of the asynchronous CAM.

All input vector are tested. In matched state as shown in figure 14, $SL$ and $D$ are ON, then $Q$ line connect to ground. That time $\overline{Q}$ keeps high state, then output of NAND gate goes to high. Figure 14 shows simulation result of CAM cell in HSPICE tool that is supported by IDEC. Figure 15 shows simulated circuit CAM with DCVSL.
4. CONCLUSIONS

This paper proposed a CAM based on DI model for asynchronous cache. We get a completion signal of CAM by using DCVSL that acts as a reference signal in the system. We designed and simulated a cache with 2.75KB CAM for 8KB instruction memory. The results show that the cache hit ratio is up to 95% based on pseudo-least recently used (LRU) replacement policy.

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